Application/Control No. O9/811,579 Applicant(s)/Patent Under Reexamination WELCHMAN ET AL. Examiner Sang Nguyen Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	Α	US-5,732,147	03-1998	Тоа	382	110
	В	US-6,031,933	02-2000	Kumagai	356	426
	С	US-5,286,532	02-1994	Yoshikawa et al.	427	356
	D	US-5,966,213	10-1999	Shimoska et al.	356	376
	E	US-5,985,370	11-1999	Ohira et al.	427	387
	F	US-				
	G	US-				
	Н	US-				
	ı	US-				
	J	US-				
	Κ	US-				
	L	US-				
	М	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N	Jp 06 016 844	01/1994	Japan	Oyachi et al.		
	0						
	Р						
	Q						
	R						
	s						
	Т						

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	w						
	х						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.